



**International
Standard**

ISO 12233

**Digital cameras — Resolution and
spatial frequency responses**

*Caméras numériques — Résolution et réponses en fréquence
spatiale*

**Fifth edition
2024-09**

iTeh Standards
(<https://standards.itih.ai>)
Document Preview

[ISO 12233:2024](https://standards.itih.ai/catalog/standards/iso/43e54ae4-437b-425b-907f-6e59dcde234/iso-12233-2024)

<https://standards.itih.ai/catalog/standards/iso/43e54ae4-437b-425b-907f-6e59dcde234/iso-12233-2024>

iTeh Standards
(<https://standards.itih.ai>)
Document Preview

[ISO 12233:2024](https://standards.itih.ai/catalog/standards/iso/43e54ae4-437b-425b-907f-6e59dcde234/iso-12233-2024)

<https://standards.itih.ai/catalog/standards/iso/43e54ae4-437b-425b-907f-6e59dcde234/iso-12233-2024>



COPYRIGHT PROTECTED DOCUMENT

© ISO 2024

All rights reserved. Unless otherwise specified, or required in the context of its implementation, no part of this publication may be reproduced or utilized otherwise in any form or by any means, electronic or mechanical, including photocopying, or posting on the internet or an intranet, without prior written permission. Permission can be requested from either ISO at the address below or ISO's member body in the country of the requester.

ISO copyright office
CP 401 • Ch. de Blandonnet 8
CH-1214 Vernier, Geneva
Phone: +41 22 749 01 11
Email: copyright@iso.org
Website: www.iso.org

Published in Switzerland

Contents

| | Page |
|--|-----------|
| Foreword | v |
| Introduction | vi |
| 1 Scope | 1 |
| 2 Normative references | 1 |
| 3 Terms and definitions | 1 |
| 4 Test conditions | 5 |
| 4.1 Test chart illumination..... | 5 |
| 4.2 Camera framing and lens focal length setting..... | 6 |
| 4.3 Camera focusing..... | 6 |
| 4.4 Camera settings..... | 6 |
| 4.5 White balance..... | 7 |
| 4.6 Luminance and colour measurements..... | 7 |
| 4.7 Gamma correction..... | 7 |
| 5 Visual resolution measurement | 7 |
| 5.1 General..... | 7 |
| 5.2 Test chart..... | 8 |
| 5.2.1 General..... | 8 |
| 5.2.2 Material..... | 8 |
| 5.2.3 Size..... | 8 |
| 5.2.4 Test patterns..... | 8 |
| 5.2.5 Test pattern modulation..... | 8 |
| 5.2.6 Positional tolerance..... | 8 |
| 5.3 Rules of judgement for visual observation..... | 9 |
| 5.3.1 Rules of judgement..... | 9 |
| 5.3.2 Example of a correct visual judgement..... | 9 |
| 6 Edge-based spatial frequency response (e-SFR) | 10 |
| 6.1 General..... | 10 |
| 6.2 Methodology..... | 13 |
| 7 Sinewave-based spatial frequency response (s-SFR) measurement | 13 |
| 8 Presentation of results | 14 |
| 8.1 General..... | 14 |
| 8.2 Resolution..... | 14 |
| 8.2.1 General..... | 14 |
| 8.2.2 Basic presentation..... | 15 |
| 8.2.3 Representative presentation..... | 15 |
| 8.3 Spatial frequency response (SFR)..... | 15 |
| 8.3.1 General..... | 15 |
| 8.3.2 Spatial frequency response..... | 15 |
| 8.3.3 Report of resolution value derived from the s-SFR..... | 16 |
| Annex A (informative) CIPA resolution chart | 18 |
| Annex B (informative) Visual resolution measurement software | 24 |
| Annex C (informative) Edge SFR test chart | 30 |
| Annex D (normative) Edge spatial frequency response (e-SFR) algorithm | 32 |
| Annex E (normative) Sine wave star test chart | 38 |
| Annex F (normative) Sine wave spatial frequency response (s-SFR) analysis algorithm | 41 |
| Annex G (informative) Colour-filtered resolution measurements | 46 |
| Annex H (informative) Units and summary metrics | 48 |

ISO 12233:2024(en)

| | |
|---|-----------|
| Annex I (informative) Original test chart defined in ISO 12233:2000 | 51 |
| Annex J (informative) Non-uniform illumination compensation for some applications | 55 |
| Annex K (informative) Derivation of correction functions | 61 |
| Annex L (informative) Acutance calculation | 65 |
| Annex M (informative) Matlab function for computing e-SFR | 68 |
| Bibliography | 73 |

iTeh Standards (<https://standards.iteh.ai>) Document Preview

[ISO 12233:2024](https://standards.iteh.ai/catalog/standards/iso/43e54ae4-437b-425b-907f-6e59dcde234/iso-12233-2024)

<https://standards.iteh.ai/catalog/standards/iso/43e54ae4-437b-425b-907f-6e59dcde234/iso-12233-2024>

Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular, the different approval criteria needed for the different types of ISO document should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

ISO draws attention to the possibility that the implementation of this document may involve the use of (a) patent(s). ISO takes no position concerning the evidence, validity or applicability of any claimed patent rights in respect thereof. As of the date of publication of this document, ISO had not received notice of (a) patent(s) which may be required to implement this document. However, implementers are cautioned that this may not represent the latest information, which may be obtained from the patent database available at www.iso.org/patents. ISO shall not be held responsible for identifying any or all such patent rights.

Any trade name used in this document is information given for the convenience of users and does not constitute an endorsement.

For an explanation of the voluntary nature of standards, the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO's adherence to the World Trade Organization (WTO) principles in the Technical Barriers to Trade (TBT), see www.iso.org/iso/foreword.html. This document was prepared by Technical Committee ISO/TC 42, Photography.

This fifth edition cancels and replaces the fourth edition (ISO 12233:2023), which was revised.

The main changes are as follows:

- The subtitle of [Annex D](#) has been corrected to state that [Annex D](#) is normative (since it was erroneously listed as informative in the 4th edition), and the reference to [Annex D](#) in [6.1](#) has been clarified to state that [Annex D](#) shall be used to implement the e-SFR algorithm.
- In [Annex D](#), the name of the function “OECF” in [Formula \(D.1\)](#) has been changed to “inverse OECF”, and the description of the equation has been clarified.
- The term “electronic still picture imaging” in the title and the term “electronic still-picture cameras” in the scope have been changed to “digital cameras”, to match current industry terminology.

Any feedback or questions on this document should be directed to the user's national standards body. A complete listing of these bodies can be found at www.iso.org/members.html.

Introduction

0.1 Purpose

The spatial resolution capability is an important attribute of a digital camera. Resolution measurement standards allow users to compare and verify spatial resolution measurements, as described in Reference [15]. This document defines terminology, test charts, and test methods for performing resolution measurements for digital cameras.

0.2 Technical background

Because digital cameras are sampled imaging systems, the term resolution is often incorrectly interpreted as the number of addressable photoelements. While there are existing protocols for determining camera pixel counts, these are not to be confused with the interpretation of resolution as addressed in this document. Qualitatively, resolution is the ability of a camera to optically capture finely spaced detail, and is usually reported as a single valued metric. Spatial frequency response (SFR) is a multi-valued metric that measures contrast loss as a function of spatial frequency. SFR is similar to the optical transfer function (OTF) and the modulation transfer function (MTF) which are defined for linear systems (see References [2] and [4]). Generally, contrast decreases as a function of spatial frequency to a level where detail is no longer visually resolved. This limiting frequency value is the resolution of the camera. A camera's resolution and its SFR are determined by several factors. These include, but are not limited to, the performance of the camera lens, the number of addressable photoelements in the optical imaging device, and the camera image processing, which can include image sharpening, image compression and gamma correction functions.

While resolution and SFR are related metrics, their difference lies in their comprehensiveness and utility. As articulated in this document, resolution is a single frequency parameter that indicates whether the output signal contains a minimum threshold of detail information for visual detection. In other words, resolution is the highest spatial frequency that a camera can usefully capture under cited conditions. It can be very valuable for rapid manufacturing testing, quality control monitoring, or for providing a simple metric that can be easily understood by end users. The algorithm used to determine resolution has been tested with visual experiments using human observers and correlates well with their estimation of high frequency detail loss.

SFR is a numerical description of how contrast is changed by a camera as a function of spatial frequencies. It is very beneficial for engineering, diagnostic, and image evaluation purposes and serves as an umbrella function from which such metrics as sharpness and acutance are derived. Often, practitioners will select the spatial frequency associated with a specified SFR level as a modified non-visual resolution value.

In a departure from the first edition of this document, two SFR measurements were described in the second edition. The first SFR metrology method, an edge-based spatial frequency response (e-SFR), was identical to that described in the first edition, except that a lower contrast edge was used for the test chart. In the fourth edition, the test chart used for the e-SFR measurement was updated, to enable measurements in diagonal directions. Regions of interest (ROIs) near slanted vertical, diagonal, and horizontal edges are digitized and used to compute the e-SFR levels. The use of a slanted edge allows the edge gradient to be measured at many phases relative to the image sensor photoelements and to yield a phase averaged e-SFR response.

A second sine wave based SFR (s-SFR) metrology method was introduced in the second edition. Using a sine wave modulated target in a polar format (e.g. Siemens star), it is intended to provide an SFR response that is more resilient to ill-behaved spatial frequency signatures introduced by the image content driven processing of some consumer digital cameras. In this sense, it is intended to enable easier interpretation of SFR levels from such cameras. Comparing the results of the edge-based SFR and the sine-based SFR might indicate the extent to which nonlinear processing is used.

The first step in determining visual resolution or SFR is to capture an image of a suitable test chart with the camera under test. The test chart should include features of sufficiently fine detail and frequency content such as edges, lines, square waves, or sine wave patterns. The test charts defined in this document have been designed specifically to evaluate digital cameras. They have not necessarily been designed to evaluate other electronic imaging equipment such as input scanners, CRT displays, hard-copy printers, or electro-photographic copiers, nor individual components of a digital camera, such as the lens.

The measurements described in this document are performed using digital analysis techniques.

0.3 Methods for measuring SFR and resolution — Selection rationale and guidance

This section is intended to provide more detailed rationale and guidance for the selection of the different resolution metrology methods presented in this document. While resolution metrology of analogue optical systems, by way of spatial frequency response, is well established and largely consistent between methodologies (e.g. sine waves, lines, edges), metrology data for such systems are normally captured under well-controlled conditions where the required data linearity and spatial isotropy assumptions hold. Generally, it is not safe to assume these conditions for files from many digital cameras, even under laboratory capture environments. Exposure and image content dependent image processing of the digital image file before it is provided as a finished file to the user prevents this. This processing yields different SFR responses depending on the features in the scene or in the case of this document, the test chart. For instance, in-camera edge detection algorithms might specifically operate on edge features and selectively enhance or blur them based on complex nonlinear decision rules. Depending on the intent, these algorithms might also be tuned differently for repetitive scene features such as those found in sine waves or bar pattern targets. Even using the constrained camera settings recommended in this document, these nonlinear operations can yield differing SFR results depending on the test chart. Naturally, this causes confusion on which test charts to use, either alone or in combination. Guidelines for selection are offered below.

Edges are common features in naturally occurring scenes. They also tend to act as visual acuity cues by which image quality is judged and imaging artefacts are manifested. This logic prescribed their use for SFR metrology in the past and current editions of this document. It is also why edge features are prone to image processing in many consumer digital cameras: they are visually important. All other imaging conditions being equal, camera SFRs using different test chart contrast edge features can be significantly different, especially with respect to their morphology. This is largely due to nonlinear image processing operations and would not occur for strictly linear imaging systems. To moderate this behaviour, in the second edition of ISO 12233, a lower contrast slanted edge feature was chosen to replace the higher contrast version of the first edition. In the fourth edition, the edge feature was further modified to enable measurements in diagonal directions. This “slanted star” feature choice still allows for acuity amenable SFR results beyond the half-sampling frequency and helps prevent nonlinear data clipping that can occur with high contrast target features. It is also a more reliable rendering of visually important contrast levels in naturally occurring scenes. However, data clipping is still possible when using a test chart having a large edge reflectance ratio and/or when the captured image of the test chart is significantly overexposed. This data clipping can cause the measured e-SFR values to be overstated.

Sine wave features have long been the choice for directly calculating the MTF of analogue imaging systems and they are intuitively satisfying. They were introduced in the second edition based on experiences from the edge-based approach. Because sine waves transition more slowly than edges, they are not prone to being identified as edges in embedded camera processors. As such, the ambiguity that image processing imposes on the SFR can be largely avoided by their use. Alternatively, if the image processing is influenced by the absence of sharp features, more aggressive processing might be used by the camera. Using the sine wave starburst test pattern (see [Figure 6](#)) adopted in the second edition along with the appropriate analysis software, a sine wave based SFR can be calculated up to the half-sampling frequency. For the same reasons stated above, the sine wave-based target is also of low contrast and consistent with that of the edge-based version. An added benefit of the target’s design over other sine targets is its compactness and bi-directional features.

Experience suggests that there is no single SFR for today’s digital cameras. Even under the strict capture constraints suggested in this document, the allowable feature sets that most digital cameras offer prevent such unique characterization. Confusion can be reduced through complete documentation of the capture conditions and camera settings for which the SFR was calculated. It has been suggested that comparing edge-based and sine wave-based SFR results under the same capture conditions can be a good tool in assessing the contribution of spatial image processing in digital cameras. See Reference [\[15\]](#).

Finally, at times a full SFR characterization is simply not required, such as in end of line camera assembly testing. Alternately, SFR might be an intimidating obstacle to those not trained in its utility. For those in need of a simple and intuitive space domain approach to resolution using repeating line patterns, a visual resolution measurement is also provided in this document.

ISO 12233:2024(en)

With such a variety of methods available for measuring resolution, there are bound to be differences in measured resolution results. To benchmark the likely variations, the committee has published the results of a pilot study using several measurement methods and how they relate to each other. These results are provided in Reference [19].

iTeh Standards (<https://standards.iteh.ai>) Document Preview

[ISO 12233:2024](https://standards.iteh.ai/catalog/standards/iso/43e54ae4-437b-425b-907f-6e59dcde234/iso-12233-2024)

<https://standards.iteh.ai/catalog/standards/iso/43e54ae4-437b-425b-907f-6e59dcde234/iso-12233-2024>

Digital cameras — Resolution and spatial frequency responses

1 Scope

This document specifies methods for measuring the resolution and the spatial frequency response (SFR) of digital cameras. It is applicable to the measurement of both monochrome and colour cameras which output digital data.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 14524, *Photography — Electronic still-picture cameras — Methods for measuring opto-electronic conversion functions (OECFs)*

3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- ISO Online browsing platform: available at <https://www.iso.org/obp>
- IEC Electropedia: available at <https://www.electropedia.org/>

3.1 addressable photoelements

number of active photoelements in an *image sensor* (3.11)

Note 1 to entry: This equals the product of the number of active photoelement lines and the number of active photoelements per line.

3.2 aliasing

output image artefacts that occur in a *sampled imaging system* (3.31) due to insufficient sampling

Note 1 to entry: These artefacts usually manifest themselves as moiré patterns in repetitive image features or as jagged stair-stepping at edge transitions.

3.3 cycles per millimetre cy/mm

spatial frequency unit defined as the number of spatial periods per millimetre

3.4 digital camera

device which incorporates an *image sensor* (3.11) and produces a digital signal representing a picture

Note 1 to entry: A digital camera is typically a portable, hand-held device. The digital signal is usually recorded on a removable or an internal memory.

3.5
edge spread function

ESF

normalized spatial signal distribution in the *linearized* (3.15) output of an imaging system resulting from imaging a theoretical infinitely sharp edge

3.6
effectively spectrally neutral

having spectral characteristics which result in a specific imaging system producing the same output as for a *spectrally neutral* (3.26) object

Note 1 to entry: Effectively spectrally neutral objects may have spectral reflectances or transmittances that vary with wavelength (are not constant) so long as they produce a neutral response using the specified imaging system. Objects that are effectively spectrally neutral with respect to one imaging system will not necessarily be so with respect to another imaging system.

3.7
gamma correction

signal processing operation that changes the relative signal levels

Note 1 to entry: Gamma correction is performed, in part, to correct for the nonlinear light output versus signal input characteristics of the display. The relationship between the logarithm (base 10) of the light input level and the output signal level, called the camera opto-electronic conversion function (OECF), provides the gamma correction curve shape for an image capture device.

Note 2 to entry: The gamma correction is usually an algorithm, lookup table, or circuit which operates separately on each colour component of an image.

3.8
horizontal resolution

resolution (3.23) value(s) measured in the longer image dimension, corresponding to the horizontal direction for a "landscape" image orientation, typically using a vertical or near vertical oriented test-chart feature

3.9
image aspect ratio

ratio of the image width to the image height

[ISO 12233:2024](#)

[s://standards.iteh.ai/catalog/standards/iso/43e54ae4-437b-425b-907f-6e59dcdde234/iso-12233-2024](https://standards.iteh.ai/catalog/standards/iso/43e54ae4-437b-425b-907f-6e59dcdde234/iso-12233-2024)

3.10
image compression

process that alters the way digital image data are encoded to reduce the size of an image file

3.11
image sensor

electronic device that converts incident electromagnetic radiation into an electronic signal

EXAMPLE Charge coupled device (CCD) array, complementary metal-oxide semiconductor (CMOS) array.

3.12
line pairs per millimetre

lp/mm

spatial frequency unit defined as the number of equal width black and white line pairs per millimetre

3.13
line spread function

LSF

normalized spatial signal distribution in the *linearized* (3.15) output of an imaging system resulting from imaging a theoretical infinitely thin line

3.14

line widths per picture height

LW/PH

spatial frequency unit for specifying the width of a feature on a *test chart* (3.27) relative to the height of the active area of the chart

Note 1 to entry: The value in LW/PH indicates the total number of lines of the same width which can be placed edge to edge within the height of a test target or within the vertical field of view of a camera.

Note 2 to entry: This unit is used whatever the orientation of the “feature” (e.g. line). Specifically, it applies to horizontal, vertical, and diagonal lines.

EXAMPLE If the height of the active area of the chart equals 20 cm, a black line of 1 000 LW/PH has a width equal to 20/1 000 cm.

3.15

linearized

digital signal conversion performed to invert the camera opto-electronic conversion function (OECF) to focal plane exposure or scene luminance

3.16

lines per millimetre

L/mm

spatial frequency unit defined as the number of equal width black and white lines per millimetre

Note 1 to entry: One line pair per millimetre (lp/mm) is equal to 2 L/mm.

3.17

modulation

normalized amplitude of signal levels

Note 1 to entry: This is the difference between the minimum and maximum signal levels divided by the average signal level.

3.18

modulation transfer function

MTF

modulus of the *optical transfer function* (3.20) [ISO 12233:2024](https://standards.iteh.ai/catalog/standards/iso/43e54ae4-437b-425b-907f-6e59dcdde234/iso-12233-2024)

<https://standards.iteh.ai/catalog/standards/iso/43e54ae4-437b-425b-907f-6e59dcdde234/iso-12233-2024>
Note 1 to entry: For the MTF to have significance, it is necessary that the imaging system be operating in an isoplanatic region and in its linear range. Because *digital cameras* (3.4) are *sampled imaging systems* (3.31) which use spatial colour sampling and typically include nonlinear processing, a meaningful MTF of the camera can only be approximated through the SFR. See ISO 15529^[4].

3.19

normalized spatial frequency

spatial frequency unit for specifying resolution characteristics of an imaging system in terms of cycles per pixel rather than in cycles/millimetre or any other unit of length

3.20

optical transfer function

OTF

two-dimensional Fourier transform of the imaging system's *point spread function* (3.21)

Note 1 to entry: For the OTF to have significance, it is necessary that the imaging system be operating in an isoplanatic region and in its linear range. The OTF is a complex function whose modulus has unity value at zero spatial frequency. See ISO 9334^[2]. Because *digital cameras* (3.4) are *sampled imaging systems* (3.31) which use spatial colour sampling and typically include nonlinear processing, a meaningful OTF of the camera can only be approximated through the SFR.

3.21

point spread function

normalized spatial signal distribution in the *linearized* (3.15) output of an imaging system resulting from imaging a theoretical infinitely small point source

3.22

reflectance

ratio of the luminous flux reflected from the surface of the chart to the luminous flux incident on the surface of the chart. The reflectance should be integrated over the range of wavelengths from at least 400 to 700 nm.

Note 1 to entry: If the camera under test is sensitive to an extended spectral range (e.g. near Infrared wavelengths), the spectral range over which the reflectance is integrated needs to include this extended spectral range.

3.23

resolution

measure of the ability of a camera system, or a component of a camera system, to depict picture detail

Note 1 to entry: The limiting resolution, visual resolution, e-SFR and s-SFR are examples of resolution measurements.

3.24

SFR10 frequency

Spatial frequency where the SFR value drops to 10 %

3.25

spatial frequency response

SFR

relative amplitude response of an imaging system as a function of input spatial frequency

Note 1 to entry: The SFR is normally represented by a curve of the output response to an input sinusoidal spatial luminance distribution of unit amplitude, over a range of spatial frequencies. The SFR is divided by its value at the spatial frequency of 0 as normalization to yield a value of 1,0 at a spatial frequency of 0.

3.25.1

edge-based spatial frequency response

e-SFR

measured amplitude response of an imaging system to a slanted-edge input

Note 1 to entry: Measurement of e-SFR is as defined in [Clause 6](#).

3.25.2

sinewave-based spatial frequency response

s-SFR

measured amplitude response of an imaging system to a range of sine wave inputs

Note 1 to entry: Measurement of s-SFR is as defined in [Clause 7](#).

3.26

spectrally neutral

exhibiting reflective or transmissive characteristics which are constant over the wavelength range of interest

3.27

test chart

arrangement of *test patterns* ([3.28](#)) designed to test particular aspects of an imaging system

3.28

test pattern

specified arrangement of spectral reflectance or transmittance characteristics used in measuring an image quality attribute

3.28.1

bi-tonal pattern

pattern that is *spectrally neutral* ([3.26](#)) or *effectively spectrally neutral* ([3.5](#)), and consists exclusively of two reflectance or transmittance values in a prescribed spatial arrangement

Note 1 to entry: Bi-tonal patterns are typically used to measure *resolution* ([3.23](#)) by using the visual resolution method.

3.28.2

hyperbolic wedge test pattern

bi-tonal pattern (3.28.1) that varies continuously and linearly with spatial frequency

Note 1 to entry: A bi-tonal hyperbolic wedge test pattern is used to measure *resolution* (3.23) by using the visual resolution method in this document.

3.29

vertical resolution

resolution (3.23) value measured in the shorter image dimension, corresponding to the vertical direction for a "landscape" image orientation, typically using a horizontal or near horizontal oriented test-chart feature

3.30

visual resolution

spatial frequency at which all of the individual black and white lines of a *test pattern* (3.28) frequency can no longer be distinguished by a human observer

Note 1 to entry: This presumes the features are reproduced on a display or print.

3.31

sampled imaging system

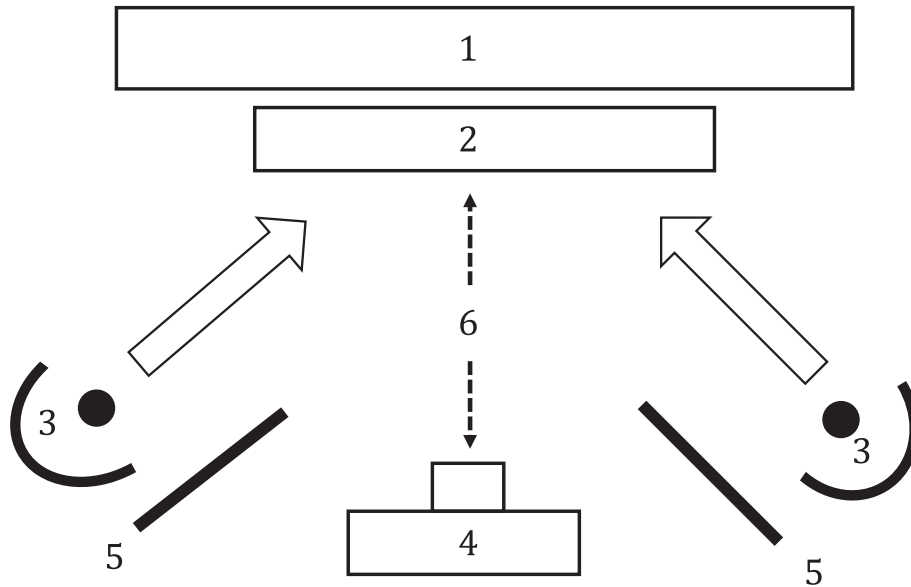
imaging system or device which generates an image signal by sampling an image at an array of discrete points, or along a set of discrete lines, rather than a continuum of points

Note 1 to entry: The sampling at each point is done using a finite-size sampling aperture or area.

4 Test conditions

4.1 Test chart illumination

The luminance of the test chart shall be sufficient to provide an acceptable camera output signal level. The test chart (key item 2) shall be uniformly illuminated as shown in [Figure 1](#), so that the illuminance at any position within the chart is within $\pm 10\%$ of the illuminance in the centre of the chart. The illumination sources (key item 3) should be baffled (key item 5) to prevent direct illumination of the camera lens by the illumination sources. The area surrounding the test chart (key item 1) should be of low reflectance to minimize flare light. The test chart should be shielded from any reflected light. The illuminated test chart shall be effectively spectrally neutral within the visible wavelengths.

**Key**

- 1 matte black wall or black surround
- 2 test chart
- 3 illumination sources
- 4 digital camera
- 5 baffles to prevent direct illumination of the camera lens
- 6 distance is adjusted to frame test chart

Figure 1 — Test chart illumination method

4.2 Camera framing and lens focal length setting

The camera shall be positioned to properly frame the test target. The vertical framing arrows are used to adjust the magnification and the horizontal arrows are used to centre the target horizontally. The tips of the centre vertical black framing arrows should be fully visible, and the tips of the centre white framing arrows should not be visible. The test chart shall be oriented so that the horizontal edge of the chart is approximately parallel to the horizontal camera frame line. The approximate distance between the camera and the test chart should be reported along with the measurement results.

4.3 Camera focusing

The camera focus should be set either by using the camera autofocus system, or by performing a series of image captures at varying focus settings and selecting the focus setting that provides the highest average modulation level at a spatial frequency approximately 1/4 the camera Nyquist frequency. (In the case of a colour camera, the Nyquist frequency is of the conceptual monochrome image sensor without colour filter array). Auto focus accuracy is often limited, and this limitation might have an impact on the results.

4.4 Camera settings

The camera lens aperture (if adjustable) and the exposure time should be adjusted to provide a near maximum signal level from the white test target areas. The settings shall not result in signal clipping in either the white or black areas of the test chart, or regions of edge transitions.

Most cameras include image compression, to reduce the size of the image files and allow more images to be stored. The use of image compression can significantly affect resolution measurements. Some cameras have settings that allow the camera to operate in various compression or resolution modes. The values of all camera settings that might affect the results of the measurement, including lens focal length, aperture and